2015 IEEE International Symposium on Electromagnetic Compatibility

(EMC 2015)

Dresden, Germany
16-22 August 2015

Pages 773-1564

IEEE Catalog Number: CFP15EMC-POD
ISBN: 978-1-4799-6617-2

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Co-Chair: Davy Pissoort, KU Leuven, Ostend, Belgium

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Co-Chair: Dave Thomas, University of Nottingham, Nottingham, United Kingdom

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SC-4 EMC for Emerging Wireless Technologies III

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Chair: Davy Pissoort, KU Leuven, Ostend, Belgium

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Chair: Vignesh Rajamani, Oklahoma State University, Stillwater, OK, USA

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Auto Electrical Power Supply

Chair: Matthias Richter, Westsächsische Hochschule, Zwickau, Germany
Co-Chair: Mark Steffka, General Motors, Milford, MI, USA

Auto Analysis Automotive Systems

Chair: Matthias Richter, Westsächsische Hochschule, Zwickau, Germany
Co-Chair: Mark Steffka, General Motors, Milford, MI, USA

THURSDAY, AUGUST 20, 2015

Thursday, August 20, 2015

TC-4 Field - Wire Coupling and Radiation I

Chair: Franco Fiori, Politecnico di Torino, Torino, Italy

TC-4 Field - Wire Coupling and Radiation II

Chair: Franco Fiori, Politecnico di Torino, Torino, Italy

SS-4 EM Field Interaction with Transmission Lines I

Chair: Jürgen Nitsch, Otto-von-Guericke University, Magdeburg, Germany

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Chair: Jürgen Nitsch, Otto-von-Guericke University, Magdeburg, Germany

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TC-2 Measurement Analysis

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Chair: Gilles Peres, Airbus Group Innovations, Toulouse, France

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Chaouki Kasmi *(French Network and Information Security Agency, Paris, France);* Olivier Maurice *(GERAC Electromagnétisme, Trappes, France);* Gabriele Gradoni *(University of Nottingham, Nottingham, United Kingdom);* Thomas Antonsen Jr. *(University of Maryland, College Park, MD, USA);* Edward Ott *(University of Maryland, College Park, MD, USA);* Steven Anlage *(University of Maryland, College Park, MD, USA)*

11:35 am **Waveguide Simulation Approach for Transmission Analysis of Reinforced Concrete Wall Structures** 941
Simon Runke *(Bergische Universität Wuppertal, Wuppertal, Germany);* Martin Zang *(Bergische Universität Wuppertal, Wuppertal, Germany);* Joachim Streckert *(Bergische Universität Wuppertal, Wuppertal, Germany);* Volkert Hansen *(Bergische Universität Wuppertal, Wuppertal, Germany);* Markus Clemens *(Bergische Universität Wuppertal, Wuppertal, Germany)*

TC-9 Practical Applications of Numerical Modelling I

Chair: Samuel Connor, IBM Corporation, RTP, NC, USA

TC-9 Practical Applications of Numerical Modelling II

Chair: Ronald Rambousky, Bundeswehr Research Inst. for Protective Technologies, Munster, Germany

TC-10 Signal and Power Integrity V

Chair: Bill Chen, Yangtze Delta Region Institute of Tsinghua University, Beijing, China

8:20 am **Compact Hybrid Open Stub EBG Structure for Power Noise Suppression in WLAN Band** ... 991
Chi-Kai Shen *(National Taiwan University, Taipei, Taiwan);* Tzong-Lin Wu *(National Taiwan University, Taipei, Taiwan)*

8:45 am **Noise Immunity Design for Multilayer Printed Circuit Boards using Elecromagnetic Simulation** 997
Mamoru Kamikura *(Mitsubishi Electric Corporation, Hyogo, Japan);* Norihiko Akashi *(Mitsubishi Electric Corporation, Hyogo, Japan);* Yuichiro Murata *(Mitsubishi Electric Corporation, Hyogo, Japan)*

9:10 am **A Black-Box Measurement-Based Modeling Method for the RF Emission and Immunity Behavior of Ics** 1002
Hugo Pues *(Melexis Technologies NV, Tessenderlo, Belgium);* Celina Gazda *(Melexis Technologies NV, Tessenderlo, Belgium)*

9:35 am **Analysis of Intra-Chip Degital Noise Coupling Path in Fully LTE Compliant RF Receiver Test Chip** 1007
Masahiro Yamaguchi *(Tohoku University, Sendai, Japan);* Peng Fan *(Tohoku University, Sendai, Japan);* Satoshi Tanaka *(Tohoku University, Sendai, Japan);* Makoto Nagata *(Kobe University, Kobe, Japan);* Sho Muroga *(National Institute of Technology, Toyota College, Toyota, Japan)*

TC-10 Signal and Power Integrity VI

Chair: Bill Chen, Yangtze Delta Region Institute of Tsinghua University, Beijing, China

10:20 am **Conducted Emission Characteristics of CCM Boost Converter with SiC Schottky Barrier Diode** 1012
Takaaki Ibuchi *(Osaka University, Suita, Osaka, Japan);*
Tsuyoshi Funaki *(Osaka University, Suita, Osaka, Japan)*
Best Student Paper Award Finalist

10:45 am **Susceptibility of Chopper OpAmps to EMI** 1018
Franco Fiori *(Politecnico di Torino, Torino, Italy)*

11:10 am **Low-Frequency Magnetic-Field Immunity Surface Scan Method** 1022
Mart Coenen *(EMCMCC, Breda, Netherlands);* Bharat Kathari *(IBI Group, New Delhi, India)*

TC-11 Nanotechnology and Advanced Materials in EMC I

Chair: MariaSabrina Sarto, Sapienza University of Rome, Rome, Italy
Co-Chair: Marina Koledintseva, Oracle, Menlo Park, CA, USA

2:00 pm **MWCNTs Nanocomposites for Space Applications** 1026
M. Nicoletto *(Thales Alenia Space Italia, Torino, Italy);* D. Boschetti *(Thales Alenia Space Italia, Torino, Italy);* M. Giorcelli *(Politecnico di Torino, Torino, Italy);* P. Savi *(Politecnico di Torino, Torino, Italy)*

2:25 pm **Optimal Terahertz Shielding Performances of Flexible Multilayer Screens based on Chemically Doped Graphene on Polymer Substrate** 1030
A.G. D'Aloia *(Sapienza University of Rome, Roma, Italy);* M. D'Amore *(Sapienza University of Rome, Roma, Italy);* M.S. Sarto *(Sapienza University of Rome, Roma, Italy)*

2:50 pm **Modelling of Multilayer Graphene (MLG)-Based Structures at Different Temperatures** ... 1036
Da-Wei Wang *(Zhejiang University, Hangzhou, China);* Wen-Sheng Zhao *(Hangzhou Dianzi University, Hangzhou, China);* Hong-Ke Ma *(Institute of Applied Electronics, Mianyang, China);* Wenchao Chen *(Zhejiang University, Hangzhou, China);* Wen-Yan Yin *(Zhejiang University, Hangzhou, China)*

3:15 pm **Electromagnetic Shielding Properties of Nano Carbon Filled Silicone Rubber Composites** ... 1041
Joseph Vimal Vas *(Indian Institute of Science, Bangalore, India);* M. Joy Thomas *(Indian Institute of Science, Bangalore, India)*
Best Student Paper Award Finalist

TC-11 Nanotechnology and Advanced Materials in EMC II

Chair: MariaSabrina Sarto, Sapienza University of Rome, Rome, Italy
Co-Chair: Marina Koledintseva, Oracle, Menlo Park, CA, USA

4:00 pm **Dynamically Reconfigurable Metamaterials for Shielding and Absorption in the GHz Range** 1047
F. de Paulis *(University of L'Aquila, L'Aquila, Italy);* C. Rizza *(University of Insubria, Como, Italy);* A. Ciattoni *(National Research Council, CNR-SPIN, L'Aquila, Italy);* E. Palange *(University of L'Aquila, L'Aquila, Italy);* A. Orlandi *(University of L'Aquila, L'Aquila, Italy)*

4:25 pm **HF Characteristics of Laminated Structure Consisting with Negative Permittivity and High Permittivity Materials** 1053
Shinichiro Yamamoto *(University of Hyogo, Himeji, Japan);* Masayoshi Okita *(University of Hyogo, Himeji, Japan);* Kenichi Hatakeyama *(University of Hyogo, Himeji, Japan);* Takanori Tsutaoka *(Hiroshima University, Higashi-Hiroshima, Japan)*

SS-5 Intentional Electromagnetic Interference (IEMI) Protection of Critical Infrastructures I

Chair: Frank Sabath, Bundeswehr Research Institute for Protective Technologies and NBC Protection, Munster, Germany

8:20 am **IEMI-Testing of Electronic Systems in Critical Infrastructure Surrounding** 1057
Ronald Rambousky *(Bundeswehr Research Institute for Protective Technologies and NBC-Protection, Munster, Germany);* André Bausen *(Bundeswehr Research Institute for Protective Technologies and NBC-Protection, Munster, Germany);* Sebastian Lange *(Bundeswehr Research Institute for Protective Technologies and NBC-Protection, Munster, Germany);* Frank Sabath *(Bundeswehr Research Institute for Protective Technologies and NBC-Protection, Munster, Germany)*

8:45 am **Analysis of IEMI Effects on a Computer Network in a Realistic Environment** 1063
Matthias Kreitlow *(Bundeswehr Research Institute for Protective Technologies and NBC Protection, Munster, Germany);* Frank Sabath *(Bundeswehr Research Institute for Protective Technologies and NBC Protection, Munster, Germany);* Heyno Garbe *(Leibniz Universität Hannover, Hannover, Germany)*

SS-5 Intentional Electromagnetic Interference (IEMI) Protection of Critical Infrastructures II

Chair: Frank Sabath, Bundeswehr Research Institute for Protective Technologies and NBC Protection, Munster, Germany

TC-5 HPEM Testing and Analysis

Chair: William Radasky, Metatech Corporation, Goleta, CA, USA
Co-Chair: Frank Sabath, Bundeswehr Research Institute for Protective Technologies and NBC Protection, Munster, Germany

TC-5 IEMI Pulsers and Effects Evaluations

Chair: William Radasky, Metatech Corporation, Goleta, CA, USA
Co-Chair: Frank Sabath, Bundeswehr Research Institute for Protective Technologies and NBC Protection, Munster, Germany

SS-3 EMC Diagnostics of Complex Systems I

Chair: Vladimir Mordachev, Belarusian State Univ. of Informatics and Radioelectronics, Minsk, Belarus

SS-3 EMC Diagnostics of Complex Systems II

Chair: Vladimir Mordachev, Belarusian State Univ. of Informatics and Radioelectronics, Minsk, Belarus

TUESDAY, AUGUST 18, 2015

Tuesday, August 18, 2015

Poster Session 1 Poster Session

Chair: Mauro Feliziani, University of L'Aquila, L'Aquila, Italy
Meet and Greet Authors 1:00 pm to 2:30 pm Tuesday.

WEDNESDAY, AUGUST 19, 2015

Wednesday, August 19, 2015

Poster Session 2

Chair: Hans Georg Krauthäuser, Technical University Dresden, Dresden, Germany
Meet and Greet Authors 1:00 pm to 2:30 pm Wednesday.

THURSDAY, AUGUST 20, 2015

Thursday, August 20, 2015

Poster Session 3

Chair: Bob Scully, NASA, Houston, TX, USA
Meet and Greet Authors 1:00 pm to 2:30 pm Thursday.